



Session Title:	[FrB1] Emerging Nitrides
Session Date:	July 17 (Fri.), 2026
Session Time:	10:20-12:05
Session Room:	Room B (Baekrok Hall B-2, 1F)
Session Chairs	

[FrB1-1] [Invited] 10:20-10:50

MOCVD of Novel Nitrides for Sustainable Electronics – AlScN and AlYN

Isabel Streicher¹, Stefano Leone², Huili Grace Xing¹, Debdeep Jena¹, and Hari Nair¹, ¹ Cornell University, USA, ² Fraunhofer Institute of Applied Solid State Physics IAF, Germany

[FrB1-2] 10:50-11:05

Growth and Structural Characterization of AlYN/GaN/Sapphire by Metalorganic Chemical-Vapor Deposition

Shun Narita, Yudai Shimizu, Daisuke Iida, Keitaro Ikejiri, and Kazutada Ikenaga, Taiyo Nippon Sanso Corporation, Japan

[FrB1-3] 11:05-11:20

Evaluation of Vertical B GaN Neutron Detectors Using Free-Standing GaN Substrate for Neutron Imaging

S. Takenaka¹, R. Kudo¹, K. Ando¹, Y. Maeda¹, E. Kokubo², K. Takagi¹, T. Oda³, M. Hino⁴, Y. Honda², H. Amano², Y. Inoue¹, T. Aoki¹, and T. Nakano¹, ¹ Shizuoka University, Japan, ² Nagoya University, Japan, ³ The University of Tokyo, Japan, ⁴ Kyoto University, Japan

[FrB1-4] 11:20-11:35

Thickness Dependence of Structural and Radiation Detection Characteristics of B GaN Neutron Detectors for In-Core Nuclear Instrumentation

R. Kudo¹, E. Kokubo², K. Takagi¹, Y. Sakurai³, H. Yashima³, T. Makino⁴, T. Ohshima⁴, Y. Honda², H. Amano², Y. Inoue¹, T. Aoki¹, and T. Nakano¹, ¹ Shizuoka University, Japan, ² Nagoya University, Japan, ³ Kyoto University, Japan, ⁴ National Institutes for Quantum Science and Technology, Japan

[FrB1-5] 11:35-11:50

Fabrication and Evaluation of BAIGaN Neutron Detector Designed for Operation in Harsh Environments

Ryusuke Suzuki¹, Ryohei Kudo¹, Toru Oikawa¹, Hinata Nakanishi¹, Eito Kokubo², Genichiro Wakabayashi³, Yoshio Honda², Hiroshi Amano², Yoku Inoue¹, Toru Aoki¹, and Takayuki Nakano¹, ¹ Shizuoka University, Japan, ² Nagoya University, Japan, ³ Kindai University, Japan

[FrB1-6] 11:50-12:05

Thickness-Dependent Compensation in Polarization-Doped Graded AlGaIn Grown by MOVPE

Abhishek Chatterjee¹, Z. S. Pehlivan¹, M. Frentrup¹, B. Harding¹, G. Kusch¹, M. J. Kappers¹, D. J. Wallis^{1,2}, and R. A. Oliver¹, ¹ University of Cambridge, United Kingdom, ² Cardiff University, United Kingdom